Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/670,434	HAO ET AL.	
Examiner	Art Unit	
Khiem D. Nauvon	2022	

	SEAR	CHED	
Class	Subclass	Date	Examiner
438	302	4/27/2005	K.N.
438	305	4/27/2005	K.n.
			<u>.</u> .
			- ·

TMI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		
			:

S (INCLUDIN	EARCH NO	TES I STRATEGY	r)
		DATE	EXMR
EAST		4/27/2005	K.N.
EAST		4/29/2005	K.W.
	·		